

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/664,686	BEHNKE ET AL.	
		Examiner	Art Unit	
		Peter Lee	2852	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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B	US-			
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E	US-			
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**FOREIGN PATENT DOCUMENTS**

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